

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>	
	10/657,181	CHIU ET AL.	
	<b>Examiner</b> An T. Luu	<b>Art Unit</b> 2816	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
See Attachment		5/23/57	AZC